Sensitivity of ZZ→IIvv to Anomalous Couplings

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- Neutral Triple Gauge Couplings
- Fit Procedure
- Results
- Outlook



Neutral Triple Gauge Couplings



- ZZZ and ZZγ vertices forbidden in SM
- Production of on-shell ZZ probes ZZZ and ZZγ anomalous couplings:

 $f_4^{Z}, f_5^{Z}, f_4^{Y}, f_5^{Y}$

• All = 0 in SM



Anomalous Couplings

- f₄ violate CP; helicity amplitudes do not interfere with SM; cross-sections depend on f₄² and sign cannot be determined
- f_5 violate P; contribute to SM at one-loop level: O(10⁻⁴)
- Couplings increase with energy. Usual to introduce a form factor to avoid violation of unitarity:

 $f_i(s') = f_{0i} / (1 + s'/\Lambda^2)^n$

- Studies below use n=3, $\Lambda = 2 \text{ TeV}$
- Also assume couplings are real and only one non-zero: use f₄^Z as example, expect results for others to be similar



Anomalous Coupling MC

- Use leading order MC of Baur + Rainwater Phys. Rev. D62 113011 (2000)
- $pp \rightarrow ZZ \rightarrow ffff$ No parton shower, underlying event, detector simulation
- CTEQ6L PDFs



SM prediction

$$\begin{split} I &= e, \, \mu \\ p_T(I) > 20 \,\, GeV \\ |\eta(I)| < 2.5 \\ p_T(vv) > 50 \,\, GeV \end{split}$$



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Signature of Anomalous Couplings



Anomalous couplings increase cross-section at high p_T

• Fit p_T distribution to obtain limits on NTGC



Fits to p_T Distribution

- Aim: estimate limits on anomalous couplings likely to be obtained from early ATLAS data from fit to Z(→II) p_T distribution in ZZ→IIvv channel:
 - Generate `fake data' samples
 - Binned max L fit to sum of signal + background
 - Determine mean 95% C.L.
- Use results from full MC (CSC samples) for event selection efficiency and background to obtain realistic limits
- Also assess effect of varying background and systematic errors



Full Simulation Results

Tom Barber

Diboson Meeting 13th August 2007

<u>11.0.4</u>	12.0.6			
ε = 3.2%	ε = 2.6%			
S/B =2.25	S/B =1.96			



Process	$ZZ \rightarrow ll \nu \bar{\nu}$	$ZZ \rightarrow 4l$	Z + jets	tī	WZ	Wt	WW	$Z \rightarrow \tau \tau$
$p_T^l > 20 \text{ GeV}, \eta_l < 2.5$	13006	5430	1.31 106	4.53 10 ⁵	27122	225	49110	2.17 105
Third lepton veto	10187	311	1.90 10 ⁵	42887	5287	75	37556	1.69 10 ⁵
$ m_{ll} - 91.2 \text{ GeV} < 10 \text{ GeV}$	10016	265	1.74 10 ⁵	11020	4530	38	8377	4014
$p_T^{\text{miss}} > 50 \text{ GeV}$								
$ p_T^{\text{miss}} - p_T^Z /p_T^Z < 0.35$								
$\phi_{\rm miss} - \phi_Z < 35^\circ$	3795	34	378	1787	942	0	1826	0
Jet Veto								
$(p_t^{jet} > 30 \text{ GeV and } \eta_{jet} < 3)$	3443	30	44	596	763	0	1668	0
$p_T(l^+l^-) > 100 \text{ GeV}$	1016	8	44	298	167	0	2	0
Statistical Error:	23	1	22	211	13	0	23	0

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Events expected in 100fb⁻¹ of data

Calculation of Signal Distribution

 Use BR MC to calculate LO cross-section at several values of f₄^Z

 $p_T(I) > 20 \text{ GeV}, |\eta(I)| < 2.5, p_T(vv) > 50 \text{ GeV}$

 Fit to quadratic in f₄^Z to obtain cross-section at arbitrary f₄^Z

- Correct for NLO effects using ratio MC@NLO / BR(SM)
- Expected number of events = cross-section x efficiency x luminosity

Signal Efficiency

Efficiency = events passing selection cuts divided by events generated with $p_T(I) > 20$ GeV, $|\eta(I)| < 2.5$, $p_T(vv) > 50$ GeV

- Efficiency from full MC using Tom's event selection
- Drops with p_T due to jet veto
- Fit results have some dependence on binning
 Reasonable variations change limits for 10 fb⁻¹ by 10 – 15%

Background Distribution

- Too few full MC events pass cuts to determine background shape
- Before cuts, background shape fairly similar to signal for $p_T > 100$ GeV
- Assume background / SM signal flat:

0.51 +- 0.21

(error from MC stats)

 Background level has only small effect on limits

`Fake Data' Samples

- Construct from expected numbers of SM signal and background events
- Add Gaussian fluctuations for systematic errors:
 - Signal: 7.2% correlated (6.5% lumi, 3% lepton ID) plus MC stat error on efficiency in each bin
 - Background: 41% correlated (MC stats)
- Add Poisson fluctuation to total number of events

Fits to p_T Distribution

- One-parameter binned maximum likelihood fit to $(f_4^Z)^2$
- Likelihood for each bin is Poisson convolved with Gaussians for nuisance parameters representing systematic errors:

 $L_{i} = \int df_{s} \int df_{b} G(f_{s},\sigma_{s}) G(f_{b},\sigma_{b}) P(n;f_{s}v_{s}+f_{b}v_{b})$ $n = number of `data' events \uparrow$ $v_{s}, v_{b} = expected signal, background Depends on f_{4}^{Z}$ $\sigma_{s}, \sigma_{b} = fractional systematic errors$

- Minimize $L = In(\Pi_i L_i)$
- 95% C.L. from L L_{min} = 1.92
- Negative (f₄^Z)² allows for downward fluctuations
- Lower bound to prevent negative predictions

Example Fit

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Test Fit

- Make `fake data' with various input values of (f₄^Z)² to test fit
- Mean fitted parameter in excellent agreement with input parameter
 (but distribution distorted by lower bound on

parameter at low luminosities for small f_4^Z)

Test fit on 100 fb⁻¹

- Compare with X² fit using full correlation matrix (only suitable for high luminosity)
- Generate 1000 fake data samples for high luminosity and fit with both fits
- Good correlation between parameter values at minimum
- 95% C.L. limits tend to be higher for max likelihood fit – seems to result from treatment of systematic errors, but not understood

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Results from Max L Fit

Lumi / fb ⁻¹	95% C.L.
1	0.023
10	0.011
30	0.0088

With as little as 1 fb⁻¹ can improve LEP limits by order of magnitude

- Mean 95% C.L. on |f₄^Z| from 1000 fits
- Background level and systematic errors not important for early data
- No background: limits improve by 10%
- No sys errors: limits improve by 7%

LEP: $|f_4^Z| < 0.3$ no form factor

Fit Variations

 Assess effect of varying background level and systematics on limits for 10 fb⁻¹

Variation	95% C.L.	Change
Default	0.0110	_
Bg / SM sig. = 0.2	0.0104	5%
No background	0.0100	10%
$\Delta sys(bg) = 20\%$	0.0108	2%
$\Delta sys(bg) = 0$	0.0106	4%
Stat errors only	0.0102	7%

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ZZ→IIII

- Work has started to include ZZ→IIII channel
- Branching ratio factor of 6 lower than vvll channel
- Efficiency much higher, background lower
- First indications are that sensitivity is similar to IIvv channel

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Summary and Outlook

- Expect to achieve worthwhile limits with as little as 1 fb⁻¹ of data (and maybe less)
- Much still to do for a `real' analysis:
 - Understand why max L fit gives higher limits
 - Unbinned likelihood fit for lowest luminosities?
 - How to determine background distribution from data?
 - Set up framework for 2-D couplings
- Include 4-lepton channel now in progress

